


<b>Search Notes</b> 	<b>Application/Control No.</b> 10810267	<b>Applicant(s)/Patent Under Reexamination</b> KAPOCHUNAS ET AL.
	<b>Examiner</b> Pardo, Thuy N	<b>Art Unit</b> 2627

SEARCHED			
Class	Subclass	Date	Examiner
707	3, 101, 102	8/3/2007	TP
711	104	8/3/2007	TP
707	102	2/16/2008	TP
713	161	2/16/2008	TP
707	3, 101, 102	11/4/2008	TP
705	400	11/4/2008	TP
379	201.02	1/23/2009	TP
379	220.01	1/23/2009	TP
707	3, 101, 102, 104.1	7/9/2009	TP
379	201.02	7/9/2009	TP

SEARCH NOTES		
Search Notes	Date	Examiner
WEST	8/3/2007	TP
WEST	2/16/2008	TP
WEST, NPL (ACM)	11/11/2008	TP
WEST, NPL (ACM)	1/23/2009	TP
WEST	7/9/2009	TP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/Thuy N Pardo/ Primary Examiner.Art Unit 2627
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